

128K X76F128 16Kx8+64x8

# Secure

#### **FEATURES**

- 64-bit Password Security
  - —Five 64-bit Passwords for Read, Program and Reset
- 16384 Byte+64 Byte Password Protected Arrays
  - -Seperate Read Passwords
  - -Seperate Write Passwords
  - -Reset Password
- Programmable Passwords
- Retry Counter Register
  - -Allows 8 tries before clearing of both arrays
  - -Password Protected Reset
- 32-bit Response to Reset (RST Input)
- 64 byte Sector Program
- 400kHz Clock Rate
- 2 wire Serial Interface
- Low Power CMOS
  - -2.7 to 5.5V operation
  - -Standby current Less than 1µA
  - -Active current less than 3 mA
- High Reliability Endurance:
  - -100,000 Write Cycles
- Data Retention: 100 years
- Available in:
  - -SmartCard Module
  - —TQFP Package

#### DESCRIPTION

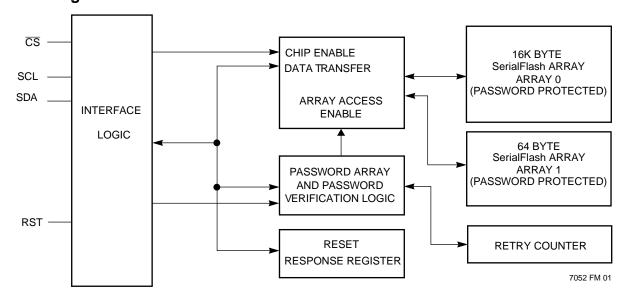
The X76F128 is a Password Access Security Supervisor, containing one 131072-bit Secure SerialFlash array and one 512-bit Secure SerialFlash array. Access to each memory array is controlled by two 64-bit passwords. These passwords protect read and write operations of the memory array. A separate RESET password is used to reset the passwords and clear the memory arrays in the event the read and write passwords are lost.

The X76F128 features a serial interface and software protocol allowing operation on a popular two wire bus. The bus signals are a clock Input (SCL) and a bidirectional data input and output (SDA). Access to the device is controlled through a chip select  $(\overline{CS})$  input, allowing any number of devices to share the same bus.

The X76F128 also features a synchronous response to reset providing an automatic output of a hard-wired 32-bit data stream conforming to the industry standard for memory cards.

The X76F128 utilizes Xicor's proprietary Direct Write<sup>TM</sup> cell, providing a minimum endurance of 100,000 cycles and a minimum data retention of 100 years.

# **Functional Diagram**



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#### **PIN DESCRIPTIONS**

#### Serial Clock (SCL)

The SCL input is used to clock all data into and out of the device.

## Serial Data (SDA)

SDA is a true three state serial data input/output pin. During a read cycle, data is shifted out on this pin. During a write cycle, data is shifted in on this pin. In all other cases, this pin is in a high impedance state.

### Chip Enable (CS)

When  $\overline{\text{CS}}$  is high, the X76F128 is deselected and the SDA pin is at high impedance and unless an internal write operation is underway, the X76F128 will be in standby mode.  $\overline{\text{CS}}$  low enables the X76F128, placing it in the active mode.

#### Reset (RST)

RST is a device reset pin. When RST is pulsed high while  $\overline{\text{CS}}$  is low the X76F128 will output 32 bits of fixed data which conforms to the standard for "synchronous response to reset".  $\overline{\text{CS}}$  must remain LOW and the part must not be in a write cycle for the response to reset to occur. See Figure 11. If at any time during the response to reset  $\overline{\text{CS}}$  goes HIGH, the response to reset will be aborted and the part will return to the standby state. The response to reset is "mask programmable" only!

#### **DEVICE OPERATION**

There are two primary modes of operation for the X76F128; Protected READ and protected WRITE. Protected operations must be performed with one of four 8-byte passwords.

The basic method of communication for the device is established by first enabling the device ( $\overline{CS}$  LOW), generating a start condition, then transmitting a command, followed by the correct password. All parts will be shipped from the factory with all passwords equal to '0'. The user must perform ACK Polling to determine the validity of the password, before starting a data transfer (see Acknowledge Polling.) Only after the correct password is accepted and a ACK polling has been performed, can the data transfer occur.

To ensure the correct communication, RST must remain LOW under all conditions except when running a "Response to Reset sequence".

Data is transferred in 8-bit segments, with each transfer being followed by an ACK, generated by the receiving device.

If the X76F128 is in a nonvolatile write cycle a "no ACK" (SDA=High) response will be issued in response to loading of the command byte. If a stop is issued prior to the nonvolatile write cycle the write operation will be terminated and the part will reset and enter into a standby mode.

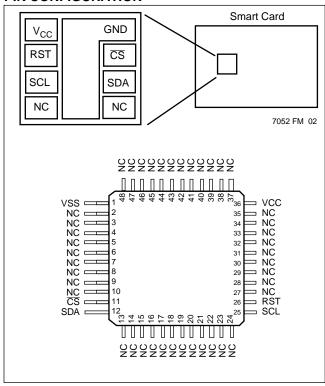
The basic sequence is illustrated in Figure 1.

#### **PIN NAMES**

Symbol	Description		
CS	Chip Select Input		
SDA	Serial Data Input/Output		
SCL	Serial Clock Input		
RST	Reset Input		
Vcc	Supply Voltage		
Vss Ground			
NC	No Connect		

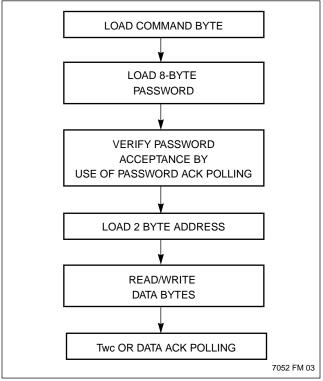
7052 FM T01

#### **PIN CONFIGURATION**



After each transaction is completed, the X76F128 will reset and enter into a standby mode. This will also be the response if an unsuccessful attempt is made to access a protected array.

Figure 1. X76F128 Device Operation



#### **Retry Counter**

The X76F128 contains a retry counter. The retry counter allows 8 accesses with an invalid password before any action is taken. The counter will increment with any combination of incorrect passwords. If the retry counter overflows, all memory areas are cleared and the device is locked by preventing any read or write array password matches. The passwords are unaffected. If a correct password is received prior to retry counter overflow, the retry counter is reset and access is granted. In order to reset the operation of a locked up device, a special reset command must be used with a RESET PASSWORD.

## **Device Protocol**

The X76F128 supports a bidirectional bus oriented protocol. The protocol defines any device that sends data onto the bus as a transmitter and the receiving device as a receiver. The device controlling the transfer is a master and the device being controlled is the slave. The master will always initiate data transfers and provide the clock for both transmit and receive operations. Therefore, the X76F128 will be considered a slave in all applications.

#### **Clock and Data Conventions**

Data states on the SDA line can change only during SCL LOW. SDA changes during SCL HIGH are reserved for indicating start and stop conditions. Refer to Figure 2 and Figure 3.

#### **Start Condition**

All commands are preceded by the start condition, which is a HIGH to LOW transition of SDA when SCL is HIGH. The X76F128 continuously monitors the SDA and SCL lines for the start condition and will not respond to any command until this condition is met.

A start may be issued to terminate the input of a control byte or the input data to be written. This will reset the device and leave it ready to begin a new read or write command. Because of the push/pull output, a start cannot be generated while the part is outputting data. Starts are inhibited while a write is in progress.

## **Stop Condition**

All communications must be terminated by a stop condition. The stop condition is a LOW to HIGH transition of SDA when SCL is HIGH. The stop condition is also used to reset the device during a command or data input sequence and will leave the device in the standby power mode. As with starts, stops are inhibited when outputting data and while a write is in progress.

## Acknowledge

Acknowledge is a software convention used to indicate successful data transfer. The transmitting device, either master or slave, will release the bus after transmitting eight bits. During the ninth clock cycle the receiver will pull the SDA line LOW to acknowledge that it received the eight bits of data.

The X76F128 will respond with an acknowledge after recognition of a start condition and its slave address. If both the device and a write condition have been selected, the X76F128 will respond with an acknowledge after the receipt of each subsequent eight-bit word.

#### **RESET DEVICE Command**

The RESET DEVICE command is used to clear the retry counter and reactivate the device. When the RESET DEVICE command is used prior to the retry counter overflow, the retry counter is reset and no arrays or passwords are affected. If the retry counter has overflowed, all memory areas are cleared and all commands are blocked and the retry counter is disabled. Issuing a valid RESET DEVICE command (with reset password) to the device resets and re-enables the retry counter and re-enables the other commands. Again, the passwords are not affected.

#### **RESET PASSWORD Command**

A RESET PASSWORD command will clear both arrays and set all passwords to all zero.

Figure 2. Data Validity

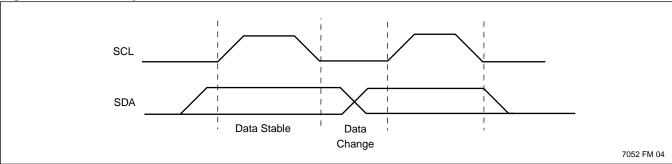


Figure 3. Definition of Start and Stop Conditions

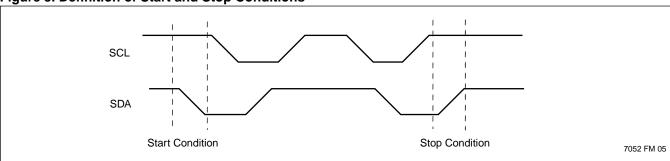


Table 1. X76F128 Instruction Set

1st Byte 2nd Byte		2nd Byte		
1st Byte after		after		Password
after Start	Password	Password	Command Description	used
1000 0000	High Address	Low address	Read (Array 0)	Read 0
1000 1000	High Address	Low address	Read (Array 1)	Read 1
1001 0000	High Address	Low address	Sector Write (Array 0)	Write 0
1001 1000	High Address	Low address	Sector Write (Array 1)	Write 1
1010 0000	0000 0000	0000 0000	Change Read 0 Password	Read 0
1010 1000	0000 0000	0000 0000	Change Read 1 Password	Read 1
1011 0000	0000 0000	0000 0000	Change Write 0 Password	Write 0
1011 1000	0000 0000	0000 0000	Change Write 1 Password	Write 1
1100 0000	0000 0000	0000 0000	Change Reset Password	Reset
1110 0000	not used	not used	RESET PASSWORD Command	Reset
1110 1000	not used	not used	RESET DEVICE Command	Reset
1111 0000	not used	not used	ACK Polling command (Ends Password operation)	None
	All the rest		Reserved	7052 FM T04

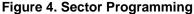
7052 FM T04

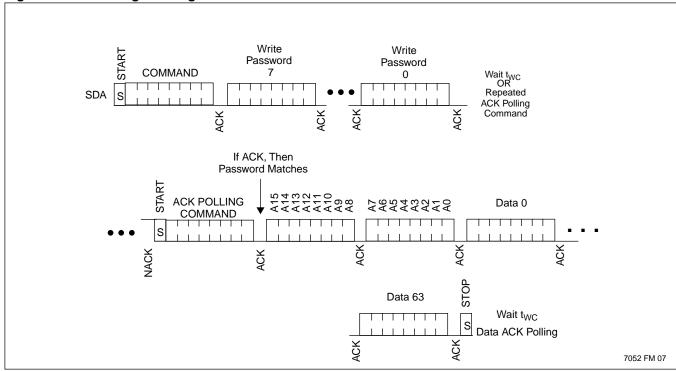
**Notes:** Illegal command codes will be disregarded. The part will respond with a "no-ACK" to the illegal byte and then return to the standby mode. All write/read operations require a password.

#### **PROGRAM OPERATIONS**

## **Sector Programming**

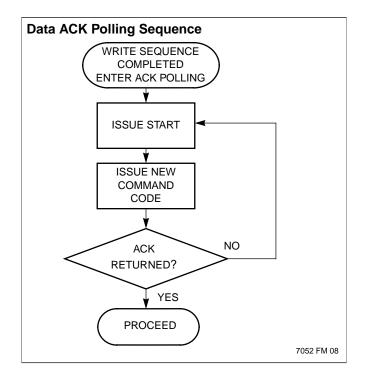
The sector program mode requires issuing the 8-bit write command followed by the password, password Ack command, the address and then the data bytes transferred as illustrated in figure 4. Up to 64 bytes may be transferred. After the last byte to be transferred is acknowledged a stop condition is issued which starts the nonvolatile write cycle.





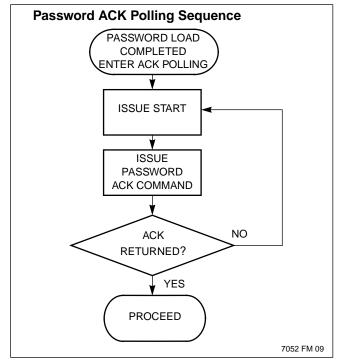
## **ACK Polling**

Once a stop condition is issued to indicate the end of the host's write sequence, the X76F128 initiates the internal nonvolatile write cycle. In order to take advantage of the typical 5ms write cycle, ACK polling can begin immediately. This involves issuing the start condition followed by the new command code of 8 bits (1st byte of the protocol.) If the X76F128 is still busy with the nonvolatile write operation, it will issue a "no-ACK" in response. If the nonvolatile write operation has completed, an "ACK" will be returned and the host can then proceed with the rest of the protocol.



After the password sequence, there is always a nonvolatile write cycle. This is done to discourage random guesses of the password if the device is being tampered with. In order to continue the transaction, the X76F128

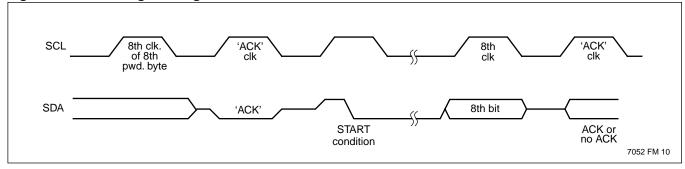
requires the master to perform an ACK polling with the specific code of F0h. As with regular Acknowledge polling the user can either time out for 10ms, and then issue the ACK polling once, or continuously loop as described in the flow.



If the password that was inserted was correct, then an "ACK" will be returned once the nonvolatile cycle is over, in response to the ACK polling cycle immediately following it.

If the password that was inserted was incorrect, then a "no ACK" will be returned even if the nonvolatile cycle is over. Therefore, the user cannot be certain that the password is incorrect until the 10ms write cycle time has elapsed.





#### **READ OPERATIONS**

Read operations are initiated in the same manner as write operations but with a different command code.

#### **Random Read**

The master issues the start condition and a Read instruction and password, performs a Password Ack Polling, then issues the word address. Once the password has been acknowledged and first byte has been read, another start can be issued followed by a new 8-bit address. Random reads are allowed, but only the low order 8 bits can change. This limits random reads to a 512 byte block. Therefore, with a single password cycle only a 512 byte block of array 0 may be accessed randomly. To randomly access another block of array 0, a stop must be issued followed by a new command/address/password sequence. A random read of the array 1 can access all locations without another password command sequence.

### **Sequential Read**

The host can read sequentially within an array after the password acceptance sequence. The data output is sequential, with the data from address n followed by the data from n+1. The address counter for read operations increments all address bits, allowing the entire memory array contents to be serially read during one operation. At the end of the address space (address 3FFFh for array 0, 3Fh for array 1), the counter "rolls over" to address 0 and the X76F128 continues to output data for each acknowledge received. Refer to figure 7 for the address, acknowledge and data transfer sequence. An acknowledge must follow each 8-bit data transfer. After the last bit has been read, a stop condition is generated without a preceding acknowledge.

Figure 6. Random Read

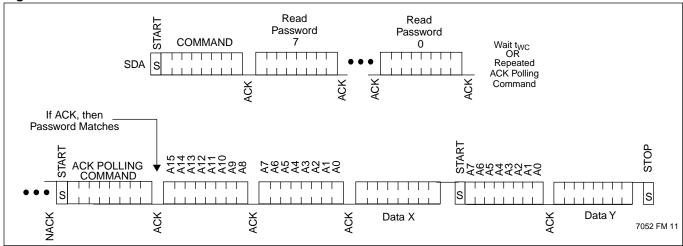
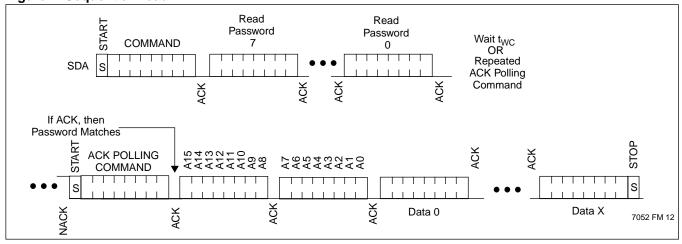


Figure 7. Sequential Read



#### **PASSWORDS**

The sequence in Figure 8 shows how to change (program) the passwords. The programming of passwords is done twice prior to the nonvolatile write cycle in order to verify that the new password is consistent. After the eight bytes are entered in the second pass, a comparison takes place. A mismatch will cause the part to reset and enter into the standby mode.

Data ACK polling can be used to determine if a password has been loaded correctly, however the data ACK command must be issued less than 2ms after the stop bit. After this time, it cannot be determined if the password has been loaded correctly, without trying the new password. To determine if the new password has been loaded correctly the data ACK polling command is issued immediately following the stop bit. If it returns an ACK, then the two passes of the new password entry do not match. If it returns a "no ACK" then the passwords match and a high voltage cycle is in progress. The high voltage cycle is complete when a subsequent data ACK command returns an "ACK".

There is no way to read any of the passwords.

Figure 8. Change Passwords

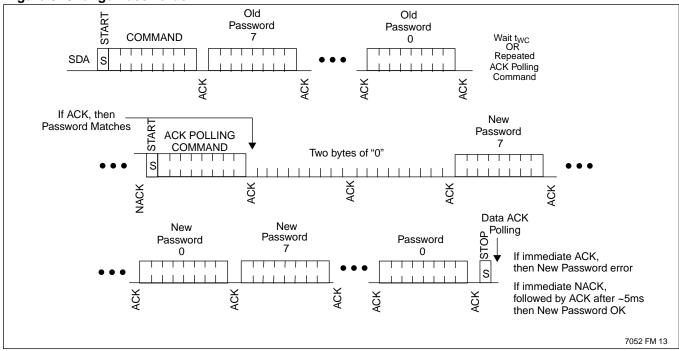
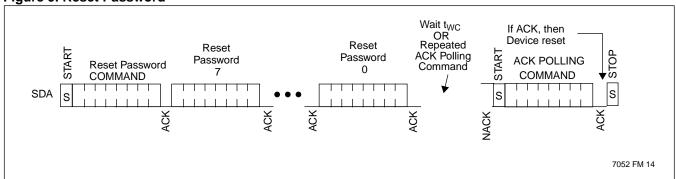
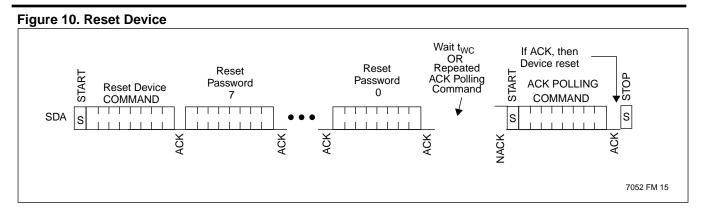


Figure 9. Reset Password



# X76F128



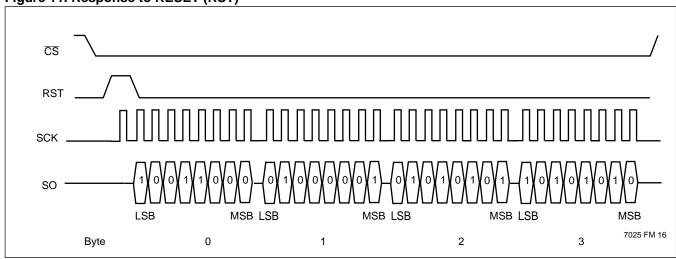
## **RESPONSE TO RESET (DEFAULT =19 28 AA 55)**

The ISO Response to reset is controlled by the RST,  $\overline{\text{CS}}$  and CLK pins. When RST is pulsed high, while  $\overline{\text{CS}}$  is low, the device will output 32 bits of data, one bit per clock. This conforms to the ISO standard for "synchronous response to reset".  $\overline{\text{CS}}$  must remain LOW and the part must not be in a write cycle for the response to reset to occur.

After initiating a nonvolatile write cycle is complete. If not, the ISO response will not be activated. Also, any attempt to pulse the RST pin in the middle of an ISO transaction will stop the transaction with the SDA pin in high impedance. The user will have to issue a stop condition and start the transaction again. If at any time during the Response to Reset  $\overline{\text{CS}}$  goes HGIH, the response to reset will be aborted and the part will return to the standby state. A Response to Reset is not available during a nonvolatile write cycle.

Continued clocks after the 32 bits, will output the 32 bit sequence again, starting at byte 0.





## **ABSOLUTE MAXIMUM RATINGS\***

Temperature under Bias	65°C to +135°C
Storage Temperature	65°C to +150°C
Voltage on any Pin with	
Respect to V <sub>SS</sub>	–1V to +7V
D.C. Output Current	5mA
Lead Temperature	
(Soldering, 10 seconds)	300°C

#### \*COMMENT

Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and the functional operation of the device at these or any other conditions above those listed in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

## **RECOMMENDED OPERATING CONDITIONS**

Temp	emp Min.	
Commercial	0°C	+70°C
Extended	–20°C	+85°C

Supply Voltage	Limits
X76F128	4.5V to 5.5V
X76F128 – 2.7	2.7V to 3.6V

FM T05

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# D.C. OPERATING CHARACTERISTICS (Over the recommended operating conditions unless otherwise specified.)

		Limits			
Symbol	Parameter	Min.	Max.	Units	Test Conditions
I <sub>CC1</sub>	V <sub>CC</sub> Supply Current (Read)		1	mA	$f_{SCL} = V_{CC} \times 0.1/V_{CC} \times 0.9$ Levels @ 400 KHz, SDA = Open RST = $\overline{CS} = V_{SS}$
I <sub>CC2</sub> <sup>(3)</sup>	I <sub>CC2</sub> <sup>(3)</sup> V <sub>CC</sub> Supply Current (Write) 3 mA		mA	$f_{SCL} = V_{CC} \times 0.1/V_{CC} \times 0.9$ Levels @ 400 KHz, SDA = Open RST = $\overline{CS} = V_{SS}$	
I <sub>SB1</sub> <sup>(1)</sup>	V <sub>CC</sub> Supply Current (Standby)		50	μA	$V_{IL} = V_{CC} \times 0.1, V_{IH} = V_{CC} \times 0.9$ $f_{SCL} = 400 \text{ KHz}, f_{SDA} = 400 \text{ KHz}$
I <sub>SB2</sub> <sup>(1)</sup>	V <sub>CC</sub> Supply Current (Standby)		1	μA	$V_{SDA} = V_{SCC} = V_{CC}$ Other = GND or $V_{CC}$ -0.3V
I <sub>LI</sub>	Input Leakage Current		10	μA	$V_{IN} = V_{SS}$ to $V_{CC}$
I <sub>LO</sub>	Output Leakage Current		10	μΑ	$V_{OUT} = V_{SS}$ to $V_{CC}$
V <sub>IL1</sub> <sup>(2)</sup>	Input LOW Voltage	-0.5	V <sub>CC</sub> x 0.3	V	V <sub>CC</sub> = 5.5V
V <sub>IH1</sub> <sup>(2)</sup>	Input HIGH Voltage	V <sub>CC</sub> x 0.7	V <sub>CC</sub> + 0.5	V	V <sub>CC</sub> = 5.5V
V <sub>IL2</sub> <sup>(2)</sup>	Input LOW Voltage	-0.5	V <sub>CC</sub> x 0.1	V	$V_{CC} = 3.0V$
V <sub>IH2</sub> <sup>(2)</sup>	Input HIGH Voltage	V <sub>CC</sub> x 0.9	V <sub>CC</sub> + 0.5	V	V <sub>CC</sub> = 3.0V
V <sub>OL</sub>	Output LOW Voltage		0.4	V	I <sub>OL</sub> = 3mA

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7052 FM T08

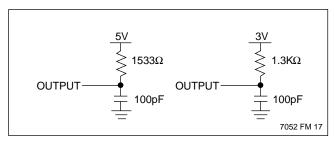
# **CAPACITANCE** $T_A = +25^{\circ}C$ , f = 1MHz, $V_{CC} = 5V$

Symbol	Test	Max.	Units	Conditions
C <sub>OUT</sub> <sup>(3)</sup>	C <sub>OUT</sub> <sup>(3)</sup> Output Capacitance (SDA)		pF	V <sub>I/O</sub> = 0V
C <sub>IN</sub> <sup>(3)</sup>	Input Capacitance (RST, SCL, $\overline{\text{CS}}$ )		pF	V <sub>IN</sub> = 0V

NOTES: (1) Must perform a stop command after a read command prior to measurement

- (2)  $V_{IL}$  min. and  $V_{IH}$  max. are for reference only and are not tested.
- (3) This parameter is periodically sampled and not 100% tested.

## **EQUIVALENT A.C. LOAD CIRCUIT**



## **A.C. TEST CONDITIONS**

Input Pulse Levels	V <sub>CC</sub> x 0.1 to V <sub>CC</sub> x 0.9
Input Rise and Fall Times	10ns
Input and Output Timing Level	V <sub>CC</sub> x 0.5
Output Load	100pF

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# X76F128

# **AC CHARACTERISTICS**

AC Specifications (Over the recommended operating conditions)

Symbol	Parameter	Min	Typ <sup>(1)</sup>	Max	Units
f <sub>SCL</sub>	SCL Clock Frequency, X76F128	0		400	KHz
f <sub>SCL</sub>	SCH Clock Frequency, X76F128–2.7	0		250	KHz
t <sub>IN</sub> <sup>(1)</sup>	Pulse width of spikes which must be suppressed by the input filter	50	100		ns
t <sub>AA</sub>	SCL LOW to SDA Data Out Valid	0.1	0.3	0.9	μѕ
t <sub>BUF</sub>	Time the bus must be free before a new transmit can start	1.3			μs
$t_{LOW}$	Clock LOW Time	1.3			μs
t <sub>HIGH</sub>	Clock HIGH Time	0.6			μs
t <sub>SU:STA</sub>	Start Condition Setup Time	0.6			μs
t <sub>HD:STA</sub>	Start Condition Hold Time	0.6			μs
t <sub>SU:DAT</sub>	Data In Setup Time	100			ns
t <sub>HD:DAT</sub>	Data In Hold Time	0			μs
t <sub>SU:STO</sub>	Stop Condition Setup Time	0.6			μs
t <sub>DH</sub>	Data Output Hold Time	50	300		ns
t <sub>R</sub>	SDA and SCL Rise Time	$20 + 0.1 \times C_b^{(2)}$		300	ns
t <sub>F</sub>	SDA and SCL Fall Time	$20 + 0.1 \times C_b^{(2)}$		300	ns
t <sub>SU:CS</sub>	CS Setup Time	200			ns
t <sub>HD:CS</sub>	CS Hold Time	100			ns
f <sub>SCL_RST</sub>	SCL Clock Frequency during Response to Reset			400	kHz
t <sub>SR</sub>	Device Select to RST active	200			ns
t <sub>NOL</sub>	RST to SCL Non-Overlap	500			ns
t <sub>RST</sub>	RST High Time	2.25			μѕ
t <sub>SU:RST</sub>	Response to Reset Setup Time	1.25			μѕ
t <sub>LOW_RST</sub>	Clock LOW during Response to Reset	1.25			μs
t <sub>HIGH_RST</sub>	Clock HIGH during Response to Reset	1.25			μs
t <sub>RDV</sub>	RST LOW to SDA Valid During Response to Reset	0		500	ns
t <sub>CDV</sub>	CLK LOW to SDA Valid During Response to Reset	0		500	ns
t <sub>DHZ</sub>	Device Deselect to SDA high impedance	0		500	ns

**Notes:** 1. Typical values are for  $T_A = 25^{\circ}C$  and  $V_{CC} = 5.0V$ 

**Notes:** 2.  $C_b = \text{Total Capacitance of one bus line in pf.}$ 

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## **RESET AC SPECIFICATIONS**

## **Power Up Timing**

Symbol	Parameter	Min.	Typ <sup>(2)</sup>	Max.	Units
t <sub>PUR</sub> <sup>(1)</sup> Time from Power Up to Read				1	mS
t <sub>PUW</sub> <sup>(1)</sup>	N <sup>(1)</sup> Time from Power Up to Write			5	mS

7052 FM T11

Notes: 1. Delays are measured from the time V<sub>CC</sub> is stable until the specified operation can be initiated. These parameters are periodically sampled and not 100% tested.

2. Typical values are for  $T_A = 25$  °C and  $V_{CC} = 5.0V$ 

# **Nonvolatile Write Cycle Timing**

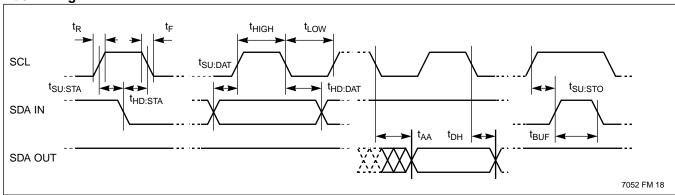
Symbol Parameter		Min.	Typ.(1)	Max.	Units
t <sub>WC</sub> <sup>(1)</sup>	Write Cycle Time		5	10	mS

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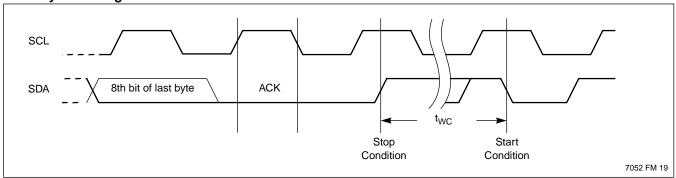
Notes: 1. t<sub>WC</sub> is the time from a valid stop condition at the end of a write sequence to the end of the self-timed internal nonvolatile write cycle. It is the minimum cycle time to be allowed for any nonvolatile write by the user, unless Acknowledge Polling is used.

# **TIMING DIAGRAMS**

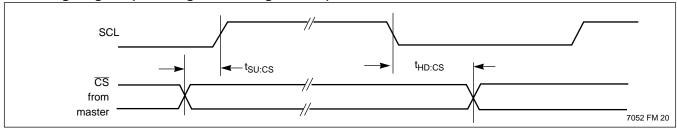
## **Bus Timing**



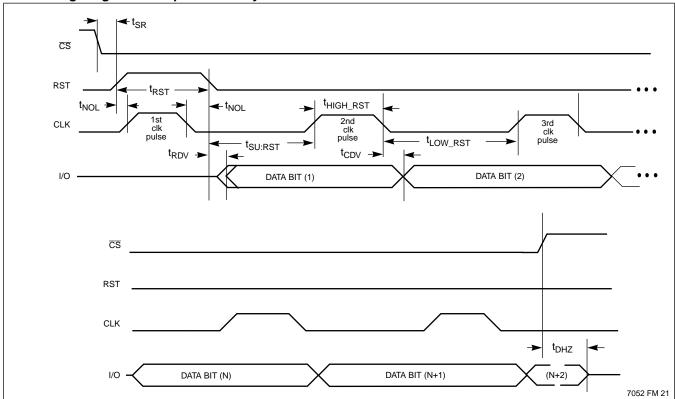
**Write Cycle Timing** 



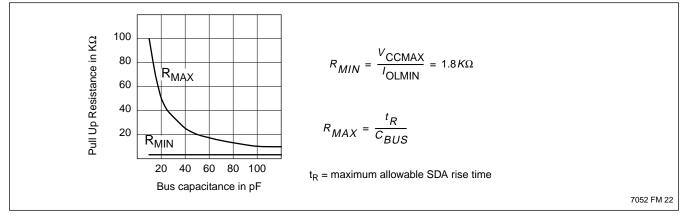
# **CS** Timing Diagram (Selecting/Deselecting the Part)



# RST Timing Diagram – Response to a Synchronous Reset

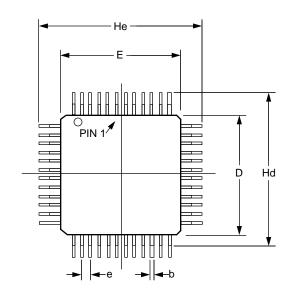


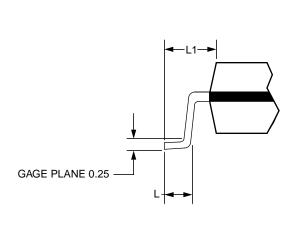
## **GUIDELINES FOR CALCULATING TYPICAL VALUES OF BUS PULL UP RESISTORS**

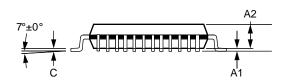


## **PACKAGING INFORMATION**

# 48-LEAD THIN QUAD FLAT PACK (TQFP) PACKAGE TYPE L







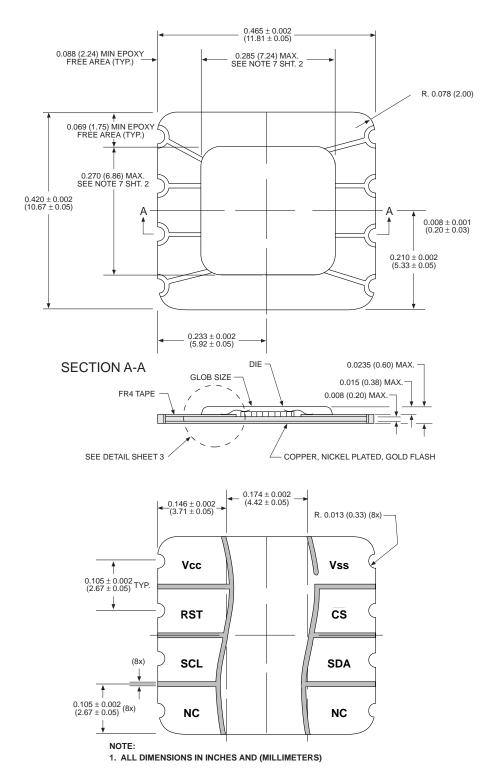
DIM	MILLIMETERS		INCHES		
	MIN	MAX	MIN	MAX	
A <sub>1</sub>	0.05	0.15	0.002	0.006	
A <sub>2</sub>	1.35	1.45	0.53	0.057	
b	0.17	0.27	0.007	0.011	
С	0.090	0.200	0.004	0.008	
D	7.0	BSC	0.273 BSC		
Е	7.0	BSC	0.273	BSC	
е	0.5	BSC	0.02 BSC		
Hd	9.0	BSC	0.35	BSC	
He	9.0 I	9.0 BSC		BSC	
L	0.45	0.75	0.018	0.030	
L <sub>1</sub>	1.00	1.00 TYP		TYP	

## NOTES:

- 1. GAGE PLANE DIMENSION IS IN MM.
- 2. LEAD COPLANARITY SHALL BE 0.10MM [0.004] MAXIMUM.
- 3. MOLD FLASH NOT INCLUDED IN DIMENSIONS

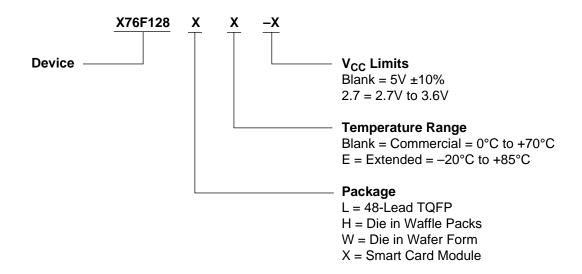
7052 FM 23

## 8 PAD CHIP ON BOARD SMART CARD MODULE TYPE X



SC Type X ILL 1.0

#### ORDERING INFORMATION



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In situations where semiconductor component failure may endanger life, system designers using this product should design the system with appropriate error detection and correction, redundancy and back-up features to prevent such an occurence.

Xicor's products are not authorized for use in critical components in life support devices or systems.

- 1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and whose failure to perform, when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.